

<b>Notice of References Cited</b>	Application/Control No. <b>09/290,419</b>	Applicant(s)/Patent Under Reexam <b>Kuribayashi</b>	
	Examiner <b>Fritz Alphonse</b>	Art Unit <b>2675</b>	Page 1 of 1

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**NON-PATENT DOCUMENTS**

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
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<sup>1</sup> Dates in MM-YYYY format are publication dates.

<sup>2</sup> Classifications may be U.S. or foreign.